

Search Notes

Application/Control No.

10/693,744

Examiner

John Kreck

Applicant(s)/Patent under
Reexamination

BAI ET AL.

Art Unit

3673

SEARCHED

| Class | Subclass | Date | Examiner |
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INTERFERENCE SEARCHED

| Class | Subclass | Date | Examiner |
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**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

| | DATE | EXMR |
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| text search attached | 12/21/2005 | JK |
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